


Search Notes 	Application/Control No. 10508789	Applicant(s)/Patent Under Reexamination NAKANISHI ET AL.
	Examiner STEVEN KAU	Art Unit 2625

SEARCHED			
Class	Subclass	Date	Examiner
358	1.9, 1.8, 3.02, 3.12, 1.15, 1.14, 1.1, 1.13, 426.01, 426.02, 426.09, 508	10/25/2008	SK
382	157, 158	10/25/2008	SK
705	411, 62, 24, 33, 408	10/25/2008	SK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search including US-PGPUB USPAT, EPO, JPO DERWENT IABM_TD and inventor search	10/25/2008	SK
PALM search	10/25/2008	SK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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